

## PATENT APPLICATION

### A CIRCUIT PATTERN INSPECTION METHOD AND APPARATUS

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Entity:            Large

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### **Correspondence Information**

Correspondence Customer Number:: 20350

### **Application Information**

Title Line One:: A CIRCUIT PATTERN INSPECTION METHOD  
Title Line Two:: AND APPARATUS  
Total Drawing Sheets:: 21  
Formal Drawings?: No  
Application Type:: Utility  
Docket Number:: 16869P017810  
Secrecy Order in Patent Appl.?: No

### **Representative Information**

Representative Customer Number:: 20350

### **Continuity Information**

This application is a:: Divisional  
> Application One:: Unassigned  
Filing Date:: February 22, 2001  
Patent Number::

which is a::  
>>Application Two::  
Filing Date::  
Patent Number::

and which is a::  
>>Application Three::  
Filing Date::  
Patent Number::

This application is a::  
>Application Four::  
Filing Date::  
Patent Number::

which is a::  
>>Application Two::  
Filing Date::  
Patent Number::

and which is a::  
>>Application Three::  
Filing Date::  
Patent Number::

### **Prior Foreign Applications**

Foreign Application One::  
Filing Date::  
Country::  
Priority Claimed::

Foreign Application Two::  
Filing Date::  
Country::  
Priority Claimed::